## METHOD FOR PROVIDING A LIFTOFF PROCESS USING A SINGLE LAYER RESIST AND CHEMICAL MECHANICAL POLISHING AND SENSOR FORMED THEREWITH

5 <u>ABSTRACT</u>

A method for providing a liftoff process using a single layer resist and chemical mechanical polishing and sensor formed therewith are disclosed. Chemical mechanical polishing is combined with liftoff using only a single resist layer to allow the removal of leftover fencing on the side of a lifted resist pattern.